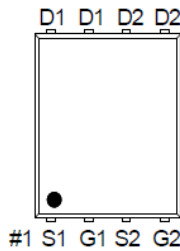


# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

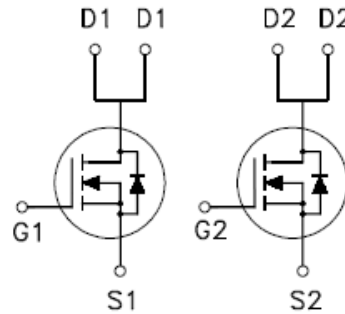
### PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
60V	38mΩ @ $V_{GS} = 10V$	15A



PDFN 5\*6P

G. GATE  
D. DRAIN  
S. SOURCE



### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ °C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	60	V
Gate-Source Voltage		$V_{GS}$	±20	
Continuous Drain Current <sup>3</sup>	$T_C = 25\text{ °C}$	$I_D$	15	A
	$T_C = 100\text{ °C}$		10	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	40	
Continuous Drain Current	$T_A = 25\text{ °C}$	$I_D$	5	
	$T_A = 70\text{ °C}$		4	
Avalanche Current		$I_{AS}$	18.6	
Avalanche Energy	$L = 0.1\text{mH}$	$E_{AS}$	17.3	mJ
Power Dissipation	$T_C = 25\text{ °C}$	$P_D$	20.8	W
	$T_C = 100\text{ °C}$		8	
Power Dissipation	$T_A = 25\text{ °C}$	$P_D$	2.3	
	$T_A = 70\text{ °C}$		1.5	
Operating Junction & Storage Temperature Range		$T_J, T_{STG}$	-55 to 150	°C

### THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		6	°C / W
Junction-to-Ambient <sup>2</sup>	$R_{\theta JA}$		55	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25\text{ °C}$ .

# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25 °C, Unless Otherwise Noted)

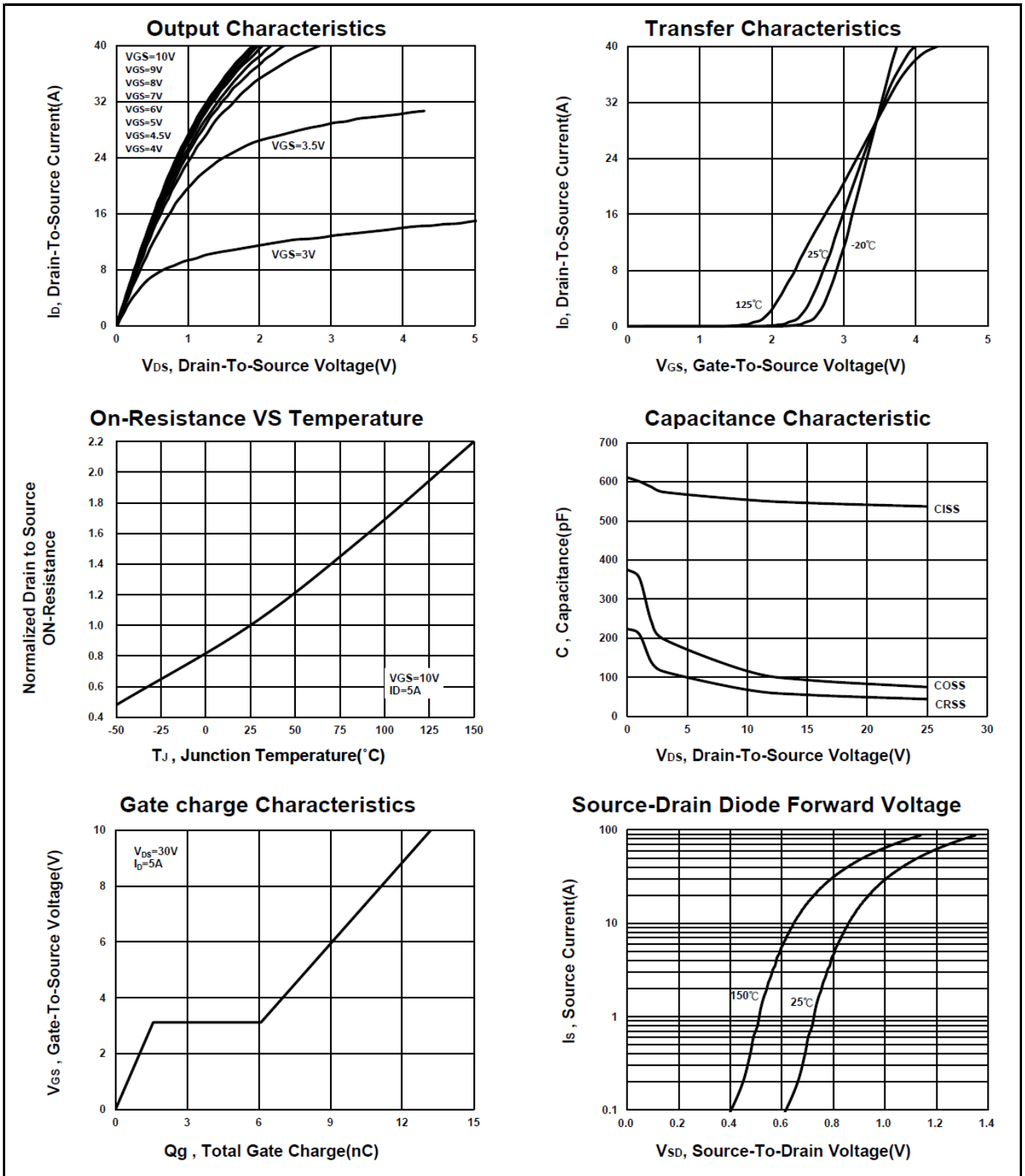
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	60			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.3	1.8	2.3	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±20V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 48V, V <sub>GS</sub> = 0V,			1	μA
		V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55 °C			10	
Drain-Source On-State Resistance <sup>1</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A		36	47	mΩ
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A		33	38	
Forward Transconductance <sup>1</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 5A		29		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1MHz		541		pF
Output Capacitance	C <sub>oss</sub>			75		
Reverse Transfer Capacitance	C <sub>rss</sub>			45		
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V, f = 1MHz		1.3		Ω
Total Gate Charge <sup>2</sup>	Q <sub>g</sub>	V <sub>GS</sub> =10V		13.3		nC
		V <sub>GS</sub> =4.5V		7.7		
Gate-Source Charge <sup>2</sup>	Q <sub>gs</sub>	V <sub>DS</sub> = 30V, I <sub>D</sub> = 5A		1.7		
Gate-Drain Charge <sup>2</sup>	Q <sub>gd</sub>			4.6		
Turn-On Delay Time <sup>2</sup>	t <sub>d(on)</sub>		V <sub>DS</sub> = 30V, I <sub>D</sub> ≅ 5A, V <sub>GS</sub> =10V, R <sub>GEN</sub> = 6Ω		16	
Rise Time <sup>2</sup>	t <sub>r</sub>			10		
Turn-Off Delay Time <sup>2</sup>	t <sub>d(off)</sub>			34		
Fall Time <sup>2</sup>	t <sub>f</sub>			10		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>J</sub> = 25 °C)</b>						
Continuous Current <sup>3</sup>	I <sub>S</sub>				15	A
Forward Voltage <sup>1</sup>	V <sub>SD</sub>	I <sub>F</sub> = 5A, V <sub>GS</sub> = 0V			1.3	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 5A, di <sub>F</sub> /dt = 100A /μS		14.6		nS
Reverse Recovery Charge	Q <sub>rr</sub>				5	

<sup>1</sup>Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

<sup>2</sup>Independent of operating temperature.

# P3606HK

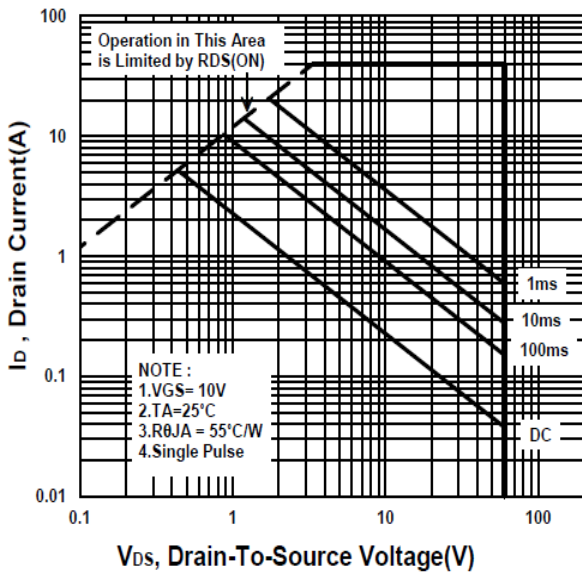
## Dual N-Channel Enhancement Mode MOSFET



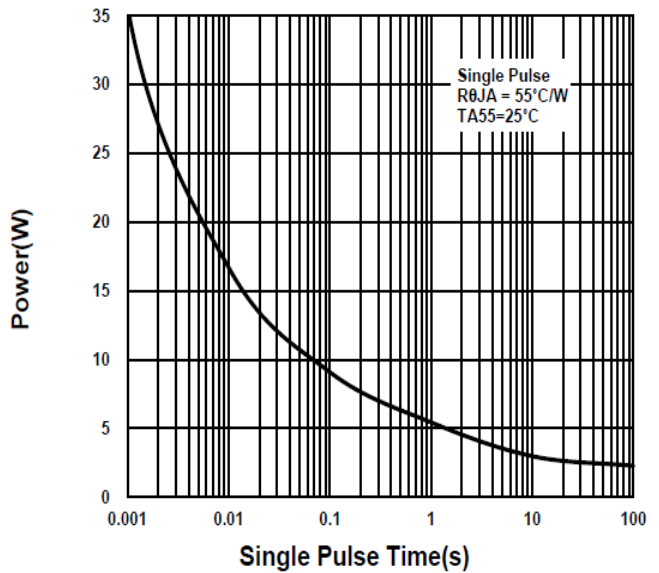
# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

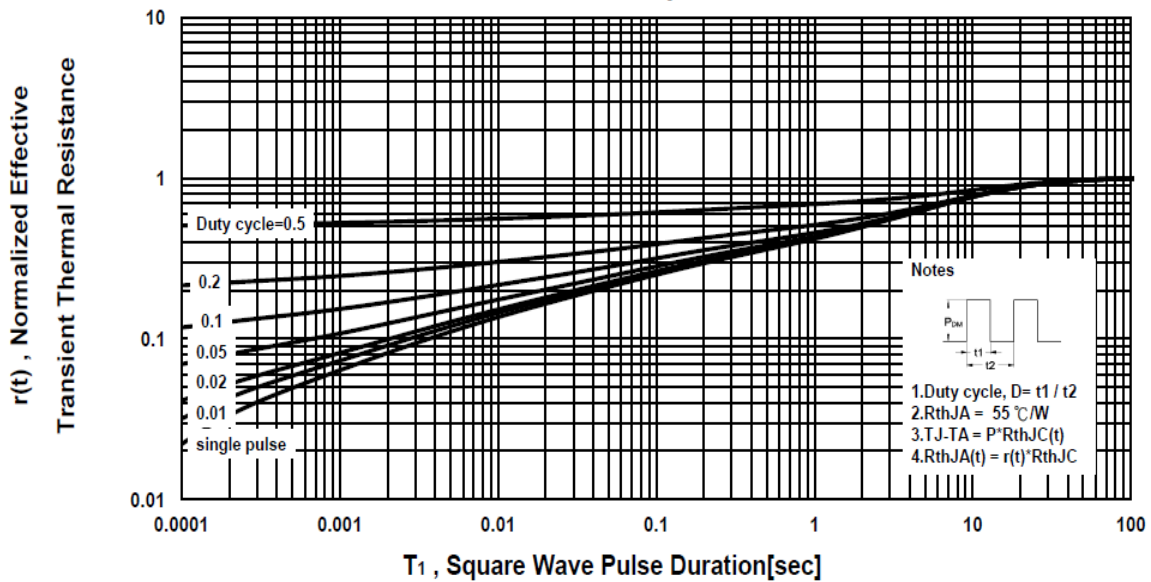
**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**



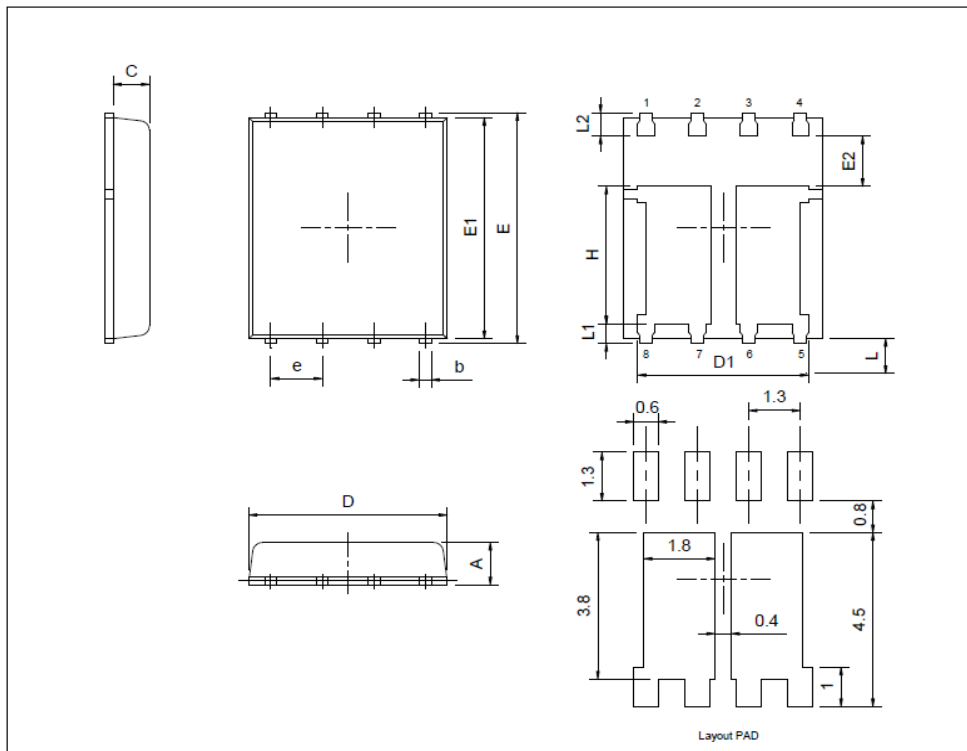
# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

### Package Dimension

### PDFN 5x6P(左右 Dual) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.9		1.17	L	0.05		0.25
b	0.33		0.51	L1	0.38		0.61
C	0.7		0.97	L2	0.38		0.71
D	4.8		5.0	H	3.38		3.78
D1	3.61		4.31				
E	5.9		6.15				
E1	5.65		5.85				
E2	1.1						
e		1.27					

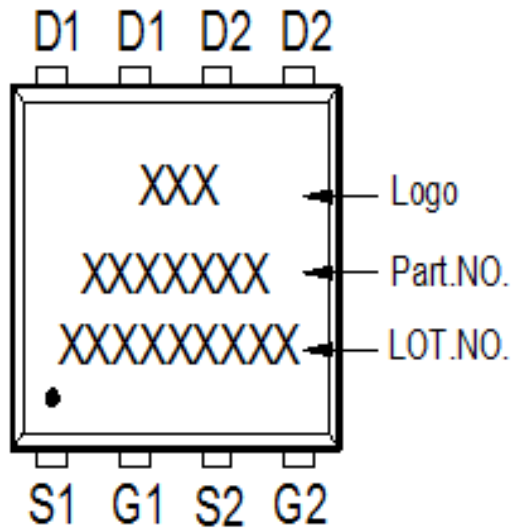


\*散热片形状会因为封装厂框架不同而有所差异。

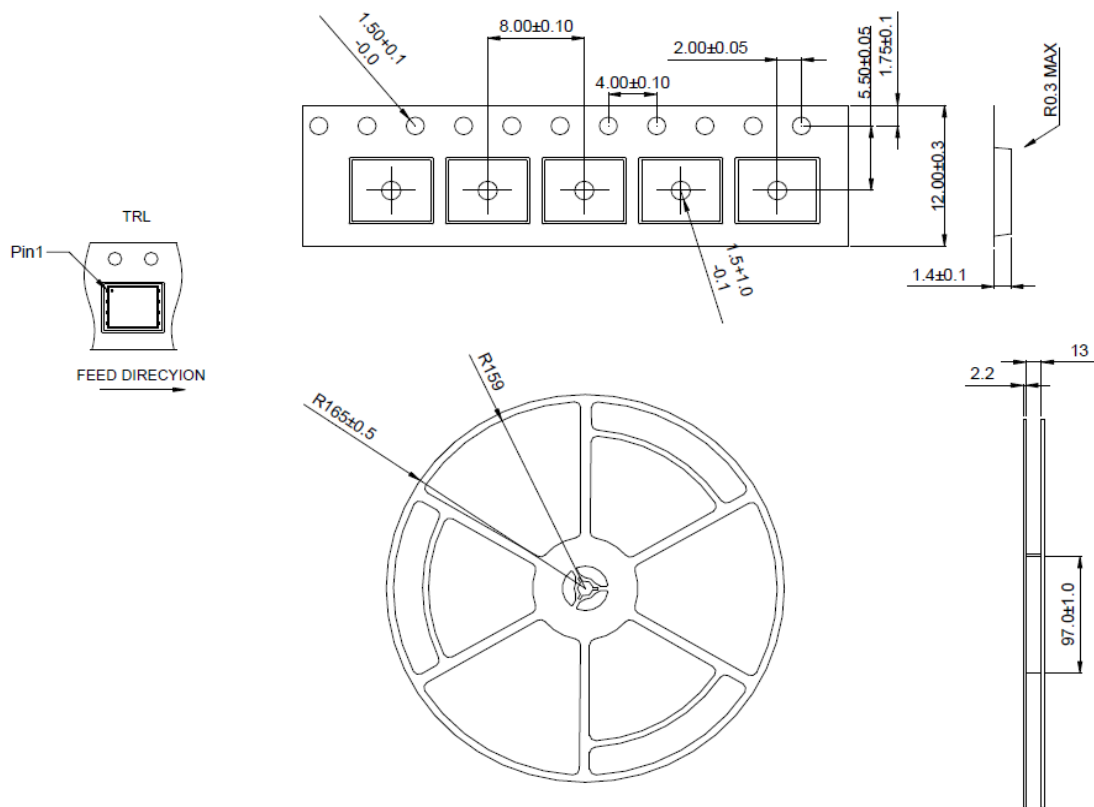
# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

### A. Marking Information



### B. Tape&Reel Information:3000pcs/Reel

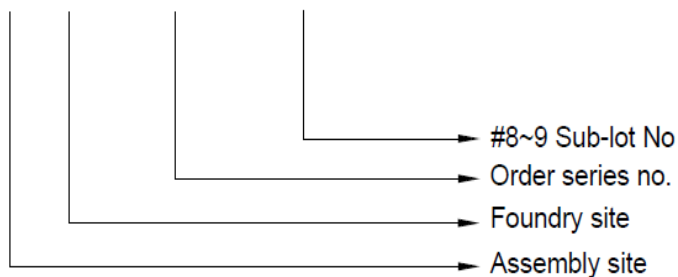


**P3606HK**  
**Dual N-Channel Enhancement Mode MOSFET**

**C. Lot.No. & Date Code rule**

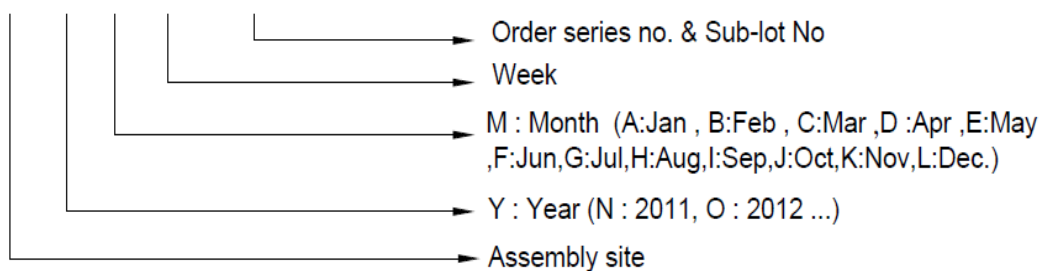
1.LOT.NO.

M N 15M21 03



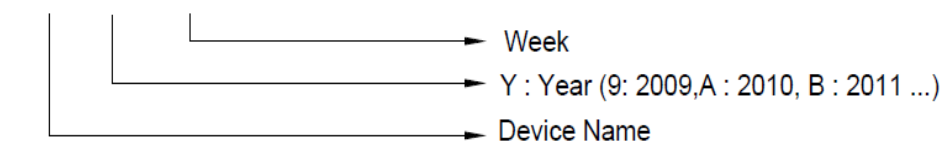
2.Date Code

D Y M X XXX



3.Date Code (for Small package)

XX Y WW





# P3606HK

## Dual N-Channel Enhancement Mode MOSFET

### D.Label rule

标签内容(Label content)



1	Label Size	30 * 90 mm
2	Font style	Times New Roman or Arial (或可区分英文”0”和数字”0”，”G和”Q”的字型即可)
3	Great Power	Height: 4 mm
4	Package	Height: 2 mm
5	Date	Height: 2 mm Shipping date: YYYY/MM/DD, ex. 2008/09/12
6	Device	Height: 3 mm (Max: 16 Digit)
7	Lot	Height: 3 mm (Max: 9 Digit) Sub lot
8	D/C	Height: 3 mm (Max: 7 Digit)
9	QTY	Height: 3 mm (Max: 6 Digit) Thousand mark is no needed
10	Pb Free label	 Diameter: 1 cm bottom color: Green Font color: Black Font style: Arial
11	Halogen Free label	 Diameter: 1 cm bottom color: Green Font color: Black Font style: Arial
12	Scan info	Device / Lot / D/C / QTY , Insert “ / “ between every parts. for example: P3055LDG/G12345601/GGG2301/2000 DPI (Dots per inch): Over 300 dpi Code : Code 128 Height: 6 mm at least